

Waveguide scattering antennas made by direct laser writing in bulk glass for spectrometry applications in the short-wave IR

M. Callejo, M. Bonduelle, A. Morand, G. Zhang, J. Lv, G. Cheng, C. D'amico, R. Stoian, G. Martin

► To cite this version:

M. Callejo, M. Bonduelle, A. Morand, G. Zhang, J. Lv, et al.. Waveguide scattering antennas made by direct laser writing in bulk glass for spectrometry applications in the short-wave IR. Applied optics, 2022, 61 (24), pp.7173-7180. 10.1364/AO.464017 . ujm-03753503

HAL Id: ujm-03753503 https://ujm.hal.science/ujm-03753503v1

Submitted on 13 Oct 2022

HAL is a multi-disciplinary open access archive for the deposit and dissemination of scientific research documents, whether they are published or not. The documents may come from teaching and research institutions in France or abroad, or from public or private research centers. L'archive ouverte pluridisciplinaire **HAL**, est destinée au dépôt et à la diffusion de documents scientifiques de niveau recherche, publiés ou non, émanant des établissements d'enseignement et de recherche français ou étrangers, des laboratoires publics ou privés.

Waveguide scattering antennas made by direct laser writing in bulk glass for spectrometry

applications in the Short-Wave Infrared

M. CALLEJO,¹ M. BONDUELLE,² A. MORAND,^{1,*} G. ZHANG,^{3,4} J. LV,³ G. CHENG,^{3,4} C. D'AMICO,³ R. STOIAN,³ AND G. MARTIN²

¹ Univ. Grenoble Alpes, Univ. Savoie Mont Blanc, CNRS, Grenoble INP, IMEP-LAHC, F-38000, Grenoble, France

² Univ. Grenoble Alpes, CNRS, IPAG, F-38400, Grenoble, France

³ Laboratoire Hubert Curien, UMR 5516 CNRS, Université de Lyon, Université Jean Monnet, 42000 St.

⁴ School of Artificial Intelligence, Optics and Electronics (iOPEN), Northwestern Polytechnical University, 11

710072 Xi'an, Shaanxi, China 12

alain.morand@univ-grenoble-alpes.fr 13

Abstract: A buried straight waveguide perturbed periodically by 6 antennas composed of 14 sub-micronic cylinder voids is entirely fabricated using ultrafast laser photoinscription. The light 15 scattered from each antenna is oriented vertically and is detected by a Short-Wave Infrared camera 16 bonded to the surface of the glass with no relay optics. The response of each antenna is analyzed 17 using a wavelength tunable laser source and compared to simulated responses verifying the 18 behaviour of the antenna. Those results show the high potential of direct laser writing technique 19 to realize monolithic embedded detectors by combining complex optical functions within a 3D 20 design. A wavelength meter application with a spectral resolution of 150pm is proposed to 21 demonstrate this combination. 22

© 2022 Optica Publishing Group 23

1. Introduction 24

In the recent years, it has been demonstrated that Direct Laser Writing (DLW) using ultrashort 25 laser pulses is a powerful solution to develop integrated photonic devices [1]. DLW provides 26 several advantages compared to the classical planar integrated optic technology. The fabrication 27 process is first a mask-less technique avoiding the use of complex multi-step photo-lithography 28 processes. Secondly, the focusing of an ultrashort laser pulse produces the excitation and a local 29 change of material properties, generating an optical function based on refractive index engineering, 30 The nonlinear absorption, limited to the focal region, gives the possibility to fabricate structures 31 in three dimensions by repositioning the laser spot [2]. By controlling the laser pulse energy and 32 its duration, the glass modification can be tuned from a smooth positive refractive index change 33 (required for the waveguiding structure) to a cavitation-induced negative refractive index change 34 creating submicronic cylinder voids [3–5]. Thus, soft excitation conditions lead to the generation 35 of waveguiding structures until nanoscale scattering centres. This modification in the glass is 36 also ensured by monitoring the shape of the focused light. This allows to have buried waveguides 37 insensitive to surface evolution and to reach symmetric waveguides with a transverse Gaussian 38 profile [6]. The refractive index contrast is rather weak (10^{-3} range), limiting the waveguide bend 39 and the compactness of functions in the component. Nevertheless, the weak numerical aperture 40 reduces the scattering at the output of the waveguide. With the same DLW technology and 41 spatial beam engineering in the shape of non-diffractive Bessel beams, it is also possible to create 42 high aspect ratio void structures with a diameter close to a few hundred nanometers [7]. These 43 elongated void structures made in the vicinity and positioned transverse to the core waveguide 44

Etienne, France 10

can convert a small part of the light going through them into scattered light propagated in the 45 glass wafer. Due to their high refractive index contrast ($\Delta n = n_{silica} - n_{void} = 0.45$ in fused 46 silica), highly efficient scattering centers are made, and they are thin enough to not perturb the 47 propagation of the light mode inside the waveguide. The use of a small cylinder void diameter is 48 also important to ensure a correct sampling of the optical guided wave which must tend ideally to 49 a Dirac comb function. The ability to create both 3D buried waveguides and cylindrical void 50 based scattering centers with the same laser source is a strong advantage of the DLW technology; 51 alternative approaches depend on complex fabrication steps that involve scanning electronic beam 52 or focused ion beam control. Since the 2000s, the association of scattered dots set periodically 53 along a waveguide ending with a mirror has been proposed to sample the stationary waves issued 54 from the superposition of a forward and a backward optical waves. With a sufficient number 55 of sampling centers (typically from one hundred to one thousand), a spectrum can be deduced 56 after a specific Fourier transform as shown in the Stationary Wave Integrated Fourier Transform 57 Spectrometer (SWIFTS) firstly demonstrated in a Gabor configuration [8,9]. Additionally with a 58 low number of sampling centers (from a dozen to twenty), a wavelength meter function can be 59 implemented using an inverted calibration matrix [10]. In a classical approach, the structures are 60 always made associating complex technologies: lift-off and e-beam writing to make submicron 61 metal lines crossing silicon photonic waveguide [9] or integrated glass waveguides [11] or focused 62 ion beam to make slot cavities in lithium-niobate waveguides [12]. In this work, the exploration 63 of DLW is proposed as an alternative to these fabrication methods. The advantages of DLW 64 enable time and cost efficient fabrication of robust wavelength meters. Indeed, the strengths 65 of this technique make it especially attractive as a prototyping tool. In this work, a waveguide 66 and several cylindrical nano-void antennas have been fabricated into a fused silica glass wafer 67 which is then coupled to a Short-Wave Infrared (SWIR) camera to measure the intensity of the 68 signal emitted by each antenna. The control and reproducibility of the response of each antenna 69 measured directly on the camera is a first step before the realization of a SWIFTS by using a 70 higher number of antennas. Despite, the low number of antennas used, another algorithm is used 71 to reach the wavelength meter function proposed previously on niobate substrate [10]. This paper 72 is divided in four sections. Firstly, the integrated optical device is described. Secondly, some 73 results issued from numerical modeling are shown to preview expected results. Thirdly, optical 74 responses obtained with a wavelength tunable laser source are shown and discussed. And finally, 75 the calibration of this same device to work as a wavelength meter is demonstrated. 76

77 2. Device description

The device is composed of a straight waveguide finished by a metallic mirror as shown in figure 1. 78 Light is coupled into the waveguide using the fiber set at the left side. There is a superposition of 79 the forward wave (solid line) and the backward wave (dashed line) inducing a stationary wave 80 inside the waveguide. As the fringe period is λ/n_g , the spatial interference pattern depends on 81 the wavelength and the refractive index of the waveguide n_g . Periodically sampling the stationary 82 wave can give access to the spectral information of the optical light source. Some conditions 83 must nevertheless be respected: firstly, the sampling dot must be much smaller than the stationary 84 wave period, linked to the minimum wavelength of the optical source. Secondly, the proportion 85 of the extracted signal must also be weak enough to leave the stationary wave undisturbed. The 86 efficiency of the scattering center used to convert the evanescent part of the stationary mode 87 into radiated power depends on the refractive index change. It must be high enough to provide 88 sufficient radiated power. Current approaches consist on nano-grooves or thin metallic stripes 89 fabricated on the sample surface. The radiated signal is either imaged on a camera [9, 16] or the 90 pixel array is bonded to the scattering centers to create a compact and optics-free device [11] 91 However, in the SWIR camera, the active area is far from the pixel physical surface (few hundred 92 micrometers), resulting in the need for a specific design of the scattering centers to control the 93

⁹⁴ directivity of the radiated light in order to limit crosstalk between sampling dots [12].



Fig. 1. Principle of the sampling centers radiating the evanescent field of the guided light toward the camera pixel without relay optic. $D = 400\mu$ m is the distance between two successive antennas and $D_0 = 59\mu$ m is the distance from the mirror and the first antenna depending of the manual polishing of the input facet. $a = 3\mu$ m is the period of the cylinder holes in one antenna. Each one-dimensional void, transverse to the propagation axis, has a diameter d < 200nm. $h_{glass} \approx 50\mu$ m is the reduced glass thickness between the surface and the waveguide position. $h_{InP} \approx 250\mu$ m and $h_{air} = 4\mu$ m. Core waveguide diameter is 50 μ m.

95 2.1. DLW features

The waveguides were fabricated in fused silica samples using an ultrafast laser photoinscription technique set in a scan configuration, with a scan of the laser spot perpendicular to the laser 97 propagation axis. A high repetition rate (100kHz) 180fs laser radiation with an energy per pulse 98 of 1.5μ J at 1030nm central wavelength from a Yb:KGW amplified laser system was used in a 99 moderate focusing configuration (NA = 0.3). The irradiation set-up allows to simultaneously 100 control the time and space envelope of the laser pulse by changing its spectral and spatial 101 phase. In a fused silica wafer, where bulk refractive index is $n_g = 1.444$ at $\lambda = 1.55 \mu$ m, the 102 refractive index modification obtained is in the range of $10^{-3} - 10^{-4}$. Due to the small refractive 103 index modification, mode field diameter is large allowing to easily set a scattering center in the 104 evanescent part without degrading the waveguide core. This technique allowing to obtain large 105 circular cross-section waveguide photo-inscription modes is based on the method reported "beam 106 slit-shaping" [17, 18]. In a second step, in order to generate the dielectric discontinuity useful 107 for the scattering center, a non-diffractive irradiation procedure is used to generate a series of 108 one-dimensional voids, transverse to the propagation axis at 3μ m from the waveguide core edge, 109 with a characteristic section below 200nm and an axial dimension above of $150\mu m$. Diameter 110 of 50nm has been already realized but a section of 200nm is a good compromise between 111 reproducibility and the length part sampled. The same ultrafast Yb:KGW amplified system at a 112 repetition rate of 100kHz, a duration of 2ps and an energy per pulse of 50μ J, is used. Instead of 113 more common Gaussian laser beams prone to nonlinear distortion effects, picoseconds pulse 114 Bessel beams with 10° half-cone angle (inside the material) were employed to generate enough 115 energy concentration to trigger material cavitation. The technique allows to avoid diffraction 116 and non linear distortions in order to create axially uniform localized uni-dimensional excitation 117 domains inside the material. Five Bessel voids arranged at a period close to $a = 3\mu m$ constitute 118 an antenna. All these voids form a small grating to scatter light in specific directions. Ideally, 119 the period should be $a = \lambda/n_{eff}$ to allow a scattering direction close to the vertical axis but 120 this value is hard to obtain experimentally at the present wavelength $(1.55\mu m)$ due to technical 121 limitations. To avoid the positioning complexity when stitching the voids in a close packing, a 122 higher order of the grating has been chosen, approximately three times higher. The consequence 123



Fig. 2. Waveguide profile schematic on the surface (x, y). Optical image of the profile waveguide on the same surface with the elongated Bessel void photo-written transverse to the propagation axis (z) at 3μ m from the waveguide core edge.



Fig. 3. Image of an antenna composed of 5 elongated Bessel voids over two photoinscribed waveguides on the surface (xz).

is the apparition of a few Bragg orders while sampling the radiated diagram of one antenna. In figure 2, a transverse section image of the waveguide associated to elongated Bessel voids is firstly shown. With the same scale, the intensity repartition of the mode observed in the second figure is larger than the core waveguide. In figure 3, an image of one antenna realized above two waveguides is shown too. Each elongated Bessel void is made above few waveguides allowing to test different straight waveguides.

The distance $D = 400 \mu m$ is then set to avoid overlapping between each antenna on the detector. 130 After the writing process, different polishing steps are done. Firstly, a polished procedure is 131 applied at the input and output facets to access to the waveguide. Indeed, due to scattering effects 132 perturbing the DLW process, the end and the beginning of the waveguide are made at 400μ m 133 from the initial facet. Secondly, the top surface is polished to reduce the glass thickness between 134 the surface and the waveguide position from 400μ m to approximately 50μ m. It is done to avoid 135 too much angular diffusion of the extracted beam before reaching the detector in order to reduce 136 the crosstalk. 137

138 2.2. Set-up

The near infrared sensor used (G12242-0707W) is provided by Hamamatsu without the glass window. It is a 2D InGaAs camera with a resolution of 16384 (128×128) pixels and a pitch of



Fig. 4. Image issued from the camera at the wave number $\sigma = 6250.0 \text{ cm}^{-1}$ ($\lambda = 1.6 \mu \text{m}$). The mirror is set at the vertical top part. The antenna 0 close to the pixel_V = 110 is the antenna set closer to the mirror. The intensity zones are associated to the scattering of each antenna. In the vertical direction, the scattering zone is enlarged due to the Bragg orders issued from the void cylinder grating. In the horizontal direction, the enlargement is smaller only associated to the waveguide mode width higher than $10\mu \text{m}$.



Fig. 5. Integration of the signal along the horizontal axis over few pixels. The vertical lines correspond to area boundaries of each antenna. The power of each antenna is calculated from the intensity integration over each segment. Line with marker \star : $\sigma = 6250.0 \text{cm}^{-1}$ ($\lambda = 1.6 \mu \text{m}$). Dashed line: $\sigma = 6622.5 \text{cm}^{-1}$ ($\lambda = 1.51 \mu \text{m}$).

 20μ m in a TO-8 package. An anti-reflection layer is set at the surface of the InP layer of the 141 sensor whose thickness is approximately $250\mu m$. All the electrical bondings and electric circuits 142 are under the surface detector, allowing to approach the glass wafer very close to the pixels. 143 Different micro-positioners (3D axis and rotation axis) are used to set the detector above the glass 144 chip that is kept still by a vacuum contact. Another 3D micropositioner is used to control the 145 fiber injection. Finally the major electric field of the polarization-maintaining fiber is oriented 146 parallel to the void cylinders. To calibrate the device, a polarized wavelength tunable laser source 147 is used. To scan the response of the device following the wavelength, the source's trigger output 148 is used and connected to the trigger input of the detector. So, at each front edge of the trigger 149 clock corresponding to a wavelength change, an image acquisition is recorded. In figure 4 and 5, 150 an example of an image is shown. The waveguide is initially aligned to one of the sensor axis. 151 6 groups are clearly observed corresponding to the 6 antennas. The vertical direction is the 152 propagation axis of the waveguide. The radiation power spreading in the transverse axis over 153 few pixels can be observed. The 2D image is then converted in a 1D trace integrating the power 154 detected along the transverse axis. 3 to 4 peaks are detected in each antenna group corresponding 155 to different Bragg orders. 156

157 3. Modeling results



Fig. 6. a) Superposition of the forward field modulus $|E_b|$ (full line) and the backward field modulus $|E_f|$ (dashed line) of the scattering field at the detector position. b) Superposition of the stationary intensity (Dashed line) and the same intensity detected integrated on the pixels (Full line). $\lambda = 1544$ nm or $\sigma = 6477$ cm⁻¹ with a length of 100 μ m between the antenna and the mirror and an hole period $a = 3.22\mu$ m.

The field emitted by a single antenna is simulated with a specific home-made numerical tool. 158 The method based on a Fourier modal decomposition is already described in [12] where it is 159 applied to a Lithium Niobate waveguide. For the simulation, the DLW waveguide is replaced 160 by a step-index waveguide: a core waveguide with a thickness of 2μ m and a refractive index of 161 1.446 surrounded by a refractive index of 1.444. The glass thickness between the glass wafer 162 surface and the core waveguide is $50\mu m$. Since the image sensor is not in direct contact with the 163 glass surface, a 4μ m air gap is included between the glass and the InP layer. The thickness of the 164 passive InP layer before the camera active layer is equal to $250\mu m$. The shape of the holes is 165 approximated by a square $(100nm \times 100nm)$ filled with air. Due to the size of the multilayer, 801 166 harmonics are chosen in the fully vectorial tool used in the first step to ensure the convergence. 167 A length of 100μ m is set between the mirror and the antenna center. This distance has been 168 chosen in order to be able to properly sample the stationary wave intensity in a wavelength range 169



Fig. 7. Evolution of the intensity of one antenna as a function of σ with a length of 100 μ m between the antenna and the mirror and an hole period $a = 3.22 \mu$ m. Optimal case with one fringe packet or one lobe of the envelope.

from 1510nm to 1600nm or a wave number from 6250 cm^{-1} to 6623 cm^{-1} . Finally, the mirror is 170 considered perfect with an amplitude reflection r = -1. The modelization of the far radiated 171 field in the active zone of the detector is made in two steps. First of all, the radiation pattern in 172 the first micrometers of the InP layer is numerically modeled with a 2D Aperiodic Fourier Modal 173 Method (AFMM) in guided configuration [13]. The electromagnetic (EM) fields were calculated 174 along a line parallel to the waveguide propagation axis in the InP layer 0.5μ m above the interface 175 InP layer. Secondly, the radiation pattern of the light diffracted in each antenna was extrapolated 176 into the far field with the Helmholtz - Kirchhoff diffraction theory [14, 15] in which the Green 177 function is approximated by an exponential one instead of Hankel functions. An antenna of 5 178 voids with a period of $3\lambda/n_g = 3.22\mu$ m is firstly simulated corresponding to the ideal case (hole 179 period exactly matching a multiple of λ/n_g). In figure 6, different scattered field moduli are 180 shown in the detector area. In this optimized case, the forward and backward field modulus (on 181 the left figure) are well superposed ensuring a high contrast of the stationary wave intensity (on 182 the right figure). In this last figure, the intensity evolution detected by each pixel (full line) is 183 also shown. The scattered light is composed of 5 Bragg orders. The width of each Bragg peak is 184 proportional to the number of voxels in a single antenna and its shape can be approximated by 185 a sinus cardinal function, whereas the envelope evolution is linked to the average shape of the 186 voxel chosen. The positions of the peaks are dependent on the wavelength. If the wave number 187 is decreased, the forward scattered field is not symmetric any more, reducing its overlapping 188 with the backward scattered field. The contrast issued from the intensity calculation in this case 189 decreases as shown in figure 7. A worse case can be reached when the wave number is close to 190 $\sigma = 6250 \text{ cm}^{-1}$ where a zero of the forward scattered field is superposed to a maximum of the 191 backward scattered field. For smaller wave number, a new fringe packet can appear but with a 192 smaller envelope contrast. Indeed, this effect can be observed when voxel period a is reduced: 193 the results for $a = 3\mu m$ are shown in figure 8 and figure 9. The Bragg order maxima are clearly 194 separated. Nevertheless, an overlapping is always possible but the forward and backward field 195 amplitudes are highly different. The principal sinus cardinal lobe of the forward field is located 196 on the secondary lobe of the backward field with a smaller amplitude. Each previous peak of the 197 intensity evolution are separated in two peaks (one from the forward wave and the other from the 198 backward wave). A fringe packet can be observed but the contrast maximum calculated at 90% 199 in the optimized case falls at 20% in this case. As the period achieved with the DLW method is 200 closer to $a = 3\mu m$ rather than $a = 3.22\mu m$, all the contrast results shown in the next part are 201 affected by the non-optimized hole period. 202



Fig. 8. a) Superposition of the forward field modulus $|E_b|$ (full line) and the backward field modulus $|E_f|$ (dashed line) of the scattering field at the detector position. b) Superposition of the stationary intensity (Dashed line) and the same intensity detected integrated on the pixels (Full line). $\lambda = 1579$ nm or $\sigma = 6333$ cm⁻¹ with a length of 100μ m between the antenna and the mirror and an hole period $a = 3\mu$ m.



Fig. 9. Evolution of the intensity of one antenna as a function of σ with a length of 100 μ m between the antenna and the mirror and a hole period $a = 3\mu$ m. Sub optimal case with two fringe packet or a zero between the lobes of the envelope.

4. Antenna response measure versus wave number



Fig. 10. Intensity response of each antenna after pixel integration as a function of the wave number (except the antenna 0 which is disturbed by the mirror reflection). The modulated evolution has been previoulsy filtered by a Butterworth band-pass filter, and the envelope signal is issued from the Hilbert transform followed once again by a Butterworth low-pass filter.

To obtain the power emitted by each antenna, the profile shown in figure 5 must be split in 6 204 segments of width $D = 400 \mu m$ defined by the successive vertical lines. The power in each zone 205 is then integrated to define the radiated power $P_i(\sigma)$ emitted by the antenna *i*. Using a tunable 206 source, the wavelength is swept from 1510nm to 1600nm with a step of 10pm. The evolution 207 of the $P_i(\sigma)$ signal is a combination of a periodical oscillation (the interference signal) with 208 an amplitude envelope and a wavelength dependent offset (mean value of the oscillation). The 209 analysis of this signal can be used to obtain useful insight into the properties of the scattering 210 centers fabricated using the DLW technique. The first step for the analysis of the signal is to 211 separate the mean value from the interference signal. This is achieved by means of a Butterworth 212 band-pass filter applied twice (equivalent to a filter of order 8 and zero delay) to avoid ripples in 213 the bandwidth zone. This treatment is coded in Python using the function butter issued from the 214 library scipy.signal. With a wavelength step of $\Delta lambda = 20$ pm (or $\Delta sigma = 0.083$ cm⁻¹), 215 the low and high cut-off frequencies used as inputs are respectively $0.05/f_{max}$ and $2/f_{max}$ with 216 $f_{max} = 1/(2\Delta sigma)$. The result of the filtering is shown in figure 10. The oscillation period of 217 each antenna is directly related to the distance between the antenna and the mirror: the period 218 decreases as the distance to the mirror increases. The envelope can be extracted by means of a 219 Hilbert transform followed by a low-pass filter to remove ripples from the result. The envelope of 220 the oscillation is shown in figure 11. 221 The envelope evolution shape depends on the number of void cylinders used in a single antenna. 222

As the hole period is close to $a = 3\mu m$, the overlapping between the forward and backward 223 scattered fields before the intensity conversion is not optimized, reducing the contrast of the fringe 224 packet observed as shown in the modelization section in figure 9. The optimized fringe packet 225 is expected to be centered at the wave number 6925 cm^{-1} , outside of the wave number range 226 observed. In theory, a zero contrast is expected between two successive fringe packets. This 227 zero appears if all voids are identical (same shape and same size). If they are not, the scattering 228 of one Bragg order is modified and the narrow peak evolution is not a sinus cardinal function 229 anymore. This result can induce an overlapping change between the forward and backward fields. 230 Having different hole sizes in a single antenna can be seen as an apodization of the fringe packet, 231 leading to the removal of the zero contrast. A simulation has been made choosing 5 holes with 232 the following arbitrary widths of 100, 140, 120, 200 and 180nm instead of the single width of 233 100nm used in the modelization part. The intensity evolution of an antenna following the wave 234



Fig. 11. Evolution of the contrast issued from the previous envelopes as a function of the wave number. The number in the legend is associated to the antenna i studied.

- number is given in figure 12 for a period $a = 3\mu m$. The contrast evolution calculated becomes 235 smoother than the single hole width case and always remains far from 0. It is clearly a hole width
- 236
- dispersion which can explain the contrast evolution measured. 237



Fig. 12. Intensity evolution as a function of σ simulated for one antenna with a length of 100 μ m between the antenna and the mirror, and an hole period $a = 3\mu$ m. Effect of manufacturing non uniform holes: 5 holes with the following widths 100, 140, 120, 200 and 180nm instead of having uniform holes with a width of 100nm. The envelope amplitude no longer goes to zero between two successive fringe packets or lobes.

A maximum contrast of 17.5% is obtained from the measurement of the device. This contrast 238 is slightly smaller than the predicted value of 19% for the case of identical holes of width 100nm. 239 This maximum contrast changes from one antenna to another. It depends on the fabrication 240 accuracy but also on the differential loss between both the forward and backward waves. Indeed, 241 the interference is maximized when the two waves have the same amplitude. However, due to the 242 different path followed and the signal extracted by the neighboring antennas, this configuration 243 changes from one antenna to another. 244

Nevertheless, the minimum contrast position should be the same for each antenna if dispersive 245 effects in the waveguide are neglected. As shown in figure 9 and figure 7, this position depends on 246 the voxel period of the antenna and can be used to analyze the reproducibility of the void cylinder 247 period in each antenna. A wave number shift can be observed, which is analysed in figure 13. The 248 diamond corresponds to simulated minimum position using the previously mentioned numerical 249



Fig. 13. Evolution of the simulated minimum contrast position as a function of the period of the cylinder holes. The horizontal lines correspond to the measured values issued from the 5 previous antennas characterized. The vertical lines are respectively an estimation of the minimum period and of the maximum period of the antennas realized.

tool [12]. The horizontal lines added on the figure are the minimum contrast wave number 250 issued from the previous measurements of the 5 characterized antennas. The period a of the void 251 cylinder is estimated between 3.078μ m and 3.111μ m. The accuracy of this period is ± 35 nm. 252

This evolution can also appear in a single antenna. 253

Fast Fourier transform of the previous signals 5. 254

From the intensity evolution as a function of the wave number, the position of each antenna can 255 be obtained using a Fast Fourier transform. A Welch [19] method has been chosen in association 256 with a Bartlett-Hann window and a padding method (4 more sampling elements). The Welch's 257 method computes an estimate of the power spectral density by dividing the data into overlapping 258 segments, computing a modified periodogram for each segment and averaging the periodograms. 259 And to limit the ripples in the frequency domain after a Fourier transform due to a rectangular 260 window, a triangular window is used for tapering the signal. The noise is reduced at the expense 261 of the resolution. The spectrum for each antenna is normalized by its maximum value and shown 262 in figure 14. Each graph on the figure is the superposition of each single antenna's spectrum. 263 The peak position gives the spatial position of the antenna. Crosstalk appears if the signal of 264 one antenna shows at the position of another antenna. Spectra of the 5 antennas for different 265 laser polarizations are shown. The separation D between each antenna associated to the single 266 antenna scattering allows to obtain a low crosstalk between each antenna in the TE polarization 267 case. Changing the polarization state, the crosstalk increases with the apparition of peaks with 268 non-negligible amplitudes at wrong positions. This is due to the radiated diagram of the TM 269 case cancelling the vertical propagation direction. The highest crosstalk is observed on the last 270 two antennas. However this effect remains reasonable in our case. It is worth noting that the 271 separation between the antennas is enough to record a major part of the TM radiated diagram. 272 For smaller separation, the device will be more sensitive to the polarization. Each peak is then 273 close to a Gaussian shape which can be used to fit each of them. In this way, the antenna position 274 can be determined with an accuracy close to a few micrometers as shown in Table 1. From a 275 linear fit of the antenna position versus the antenna number, it is notably interesting to determine 276 the distance D_0 between the first antenna and the mirror as well as the spatial separation D 277 between two successive antennas. Indeed, the value of D_0 is difficult to determine precisely after 278 the polishing steps. The respective values calculated from the fitting are $D = 402 \pm 1 \mu m$ and 279 $D_0 = 59 \pm 2\mu m.$ 280

281 6. Wavelength meter

²⁸² Spectral information can be extracted from our system with a reduced number of antennas.

²⁸³ Therefore, all the pixels analysed along a propagation axis line are used to define a calibration

matrix with a first wavelength scan from 1510nm to 1600nm and a step of 40pm. This calibration

- gives a matrix with a shape $N_{Pixel} \times N_{\lambda}$ with $N_{Pixel} = 128$ the pixel number along a line and
- $N_{\lambda} = 1751$ the number of scanned wavelengths. The intensity pixel vector I_p measured can then be linked to the wavelength vector to find λ as $I_p = M\lambda$. Two methods are then proposed. The
- first one is a least mean square solution to minimize the norm $|I_p M\lambda|^2$. The second solution
- consists in directly calculating $M_f^{-1}I_p$ and select the maximum value. M_f is not the inverted
- matrix of *M* but the pseudo inverse matrix where all values smaller than r_{cond} .max(*SVD*) are
- forced to zero with $1 \ge r_{cond} \ge 0$ and SVD a vector containing the singular values of M. The
- value of the cutoff has been manually chosen to be $r_{cond} = 0.4$.



Fig. 14. Spectrum of the intensity evolution for different polarization states. $S_{rel}(x) = \sum S_{rel,i}(x)$ and $S_{rel,i}(x)$ is the power issued from the antenna *i* and normalized as $S_{rel,i}(x) = P_{Ant,i}(x)/max(P_{Ant,i}(x))$. From the up, the first and the second graphs are respectively for the *TE* polarization (0°) and *TM* polarization (90°) cases. Each peak is associated to the response of a single antenna studied.



Fig. 15. a) Comparison of the two methods used to analyse the wavelength meter efficiency (Least mean square method and Pseudo inverse matrix method with $r_{cond} = 0.001$. b) Evolution of the error between the reference and the wavelength tested.

The effectiveness of these methods has been tested by using another wavelength sweep measurement, performed under the same conditions but with a different wavelength step of 200pm, from 1520nm to 1560nm. The results of both methods are shown in figure 15. Some cases are not well restored by both methods, and in particular for the least squares approach (+ markers). There are more + markers than o markers. But the pseudo inverse method seems to be more efficient notably for wavelengths higher than 1540nm. It is noteworthy that the error is under 0.15nm in the wavelength range observed despite the limited number of antennas. To improve this method with the same antenna number, it would be more interesting to use antennas with different period, size ... This is a first step to analyse and confirm the response of this radiated power extraction solution to sample the stationary wave of an integrated waveguide.

n	1	2	3	4	5	Error
$f/2n_g \ [\mu m]$	467	872	1277	1686	2091	±10

Table 1. Evolution of the spatial peak position issued from the intensity evolution spectrum.

303 Conclusion

A novel approach to signal sampling using DLW voxels and waveguides has been proposed. It is 304 demonstrated that each scattering center, made by a group of parallel and periodic elongated 305 Bessel nano-voids (an antenna), is able to transversally scatter a signal which is proportional to 306 the integrated optic stationary wave inside the waveguide at a given discrete position from the 307 end mirror. The measured spectral response is close to the expected response. The wavelength 308 scan can be used to give information about the morphology of the Bessel nano-voids. The 309 reproducibility of the DLW technology is from our point of view sufficient to test it along a longer 310 waveguide with a higher number of antennas in order to implement a SWIFTS. However, in order 311 to increase the contrast and have a more compact device, the period of the nano-voids forming an 312 antenna must be chosen closer to $p\lambda/n_{eff}$ with p an integer. In this paper, the achieved period is 313 close to $a = 3.1 \mu m$ nm rather than $a = 3.22 \mu m$, thus inducing a change of Bragg orders and 314 limiting the contrast to 17.5% instead of an expected value close to 90% in the optimized case. 315 For future improvements the challenge will be the reduction of this period to p = 1. In this case, 316 only one Bragg order will be excited by an antenna ensuring high contrast, large wavelength 317 bandwidth to analyse and reduced cross-talk. 318

Funding. The authors acknowledge funding from ASHRA (Action Specifique Haute Resolution Angulaire)

from INSU-CNRS, LabEx FOCUS ANR-11-LABX-0013 and LabEx Manutech-SISE ANR-10-LABX-0075.

321 G. Zhang acknowledges China Scholarship Council fellowship.

322 Disclosures. The authors declare no conflicts of interest.

323 References

- K. M. Davis, K. Miura, N. Sugimoto and K. Hirao "Writing waveguides in glass with a femtosecond laser," Opt. Lett.
 21, 1729–1731 (1996).
- A. Rodenas, G. Martin, B. Arezki, N. Psaila, G. Jose, A. Jha, L. Labadie, P. Kern, A. Ajoy and R. Thomson
 "Microstructuring of Nd: YAG crystals by proton-beam writing," Opt. Lett. 37 392–394 (2012).
- M. K. Bhuyan, F. Courvoisier, P. Ã. Lacourt, M. Jacquot, R. Salut, L. Furfaro and J. M. Dudley "High aspect ratio nanochannel machining using single shot femtosecond Bessel beams," Appl. Phys. Lett. 97 081102 (2010).
- M. Bhuyan, P. K. Velpula, J. P. Colombier, T. Olivier, N. Faure and R. Stoian "Single-shot high aspect ratio bulk nanostructuring of fused silica using chirp-controlled ultrafast laser Bessel beams," Appl. Phys. Lett. 104 021107 (2014).
- R. Stoian, M. Bhuyan, G. Cheng, G. Zhang, R. Meyer, and F. Courvoisier "Ultrafast Bessel beams: advanced tools for laser materials processing," Adv. Opt. Technol. **7** 165–174 (2018).
- 6. C. D'Amico, G. Cheng, C. Mauclair, J. Troles, L. Calvez, V. Nazabal, C. Caillaud, G. Martin, B. Arezki, E. LeCoarer,
- P. Kern and R. Stoian "Large-mode-area infrared guiding in ultrafast laser written waveguides in Sulfur-based
 chalcogenide glasses," Opt. Express 22 13091–13101 (2014).

- Zhang Z., Cheng G., Bhuyan M., D'Amico C. and Stoian R. "Efficient point-by-point Bragg gratings fabricated in embedded laser-written silica waveguides using ultrafast Bessel beams," Opt. Lett. 43 2161–2164 (2018).
- Thomas F., Heidmann S., De Mengin M., Courjal N., Ulliac G., Morand A., Benech P., Le Coarer E. Martin G.
 "First results in near and mid IR lithium niobate-based integrated optics interferometer based on SWIFTS-Lippmann
- ³⁴² concept," J. Light. Technol., **32** 3736–3742 (2014).
- Le Coarer E., Blaize S., Benech P., Stefanon I., Morand A., Lerondel G., Leblond G., Kern P., Fedeli J-M and Royer
 P. "Wavelength-scale stationary-wave integrated Fourier-transform spectrometry," Nat. Photonics 1 473–478 (2004).
- wavelength-scale stational y-wave integrated Fourier-transform spectrometry, Tvat. Friotometry 1475-478 (2004).
 Bonduelle M., Heras I., Morand A., Ulliac G., Salut R., Courjal N. and Martin G. "Near IR stationary wave Fourier
- ¹ transform lambda meter in lithium niobate: multiplexing and improving optical sampling using spatially shifted
 ³⁴⁶ nanogroove antenna," Appl. Opt. **19** D83–92 (2021).
- 11. Bonneville C., Thomas F., De Mengin Poirier M., Le Coarer E., Benech P., Gonthiez T., Morand A., Coutant
 O., Morino E., Puget R. and Martin B. "SWIFTS: a groundbreaking integrated technology for high-performance
 spectroscopy and optical sensors," Proceeding SPIE MOEMS Miniaturized Syst. XII 86160M (2013).
- 12. Morand A., Heras I., Ulliac G., Le Coarer E., Benech P., Courjal N and Martin G. "Improving the vertical radiation
 pattern issued from multiple nano-groove scattering centers acting as an antenna for future integrated optics Fourier
 transform spectrometers in the near IR," Opt. Lett. 44 542–545 (2019).
- Bucci D., Martin B. and Morand A. "Application of the three-dimensional aperiodic Fourier modal method using arc
 elements in curvilinear coordinates," J. Opt. Soc. Am. A 29 367–373 (2012).
- 14. Marcuse D. "Light Transmission Optics," (Van Nostrand Rinhold Company) (1972).
- Martin B., Morand A., Benech P., Leblond G., Blaize S., Lerondel G., Royer P., Kern P. and Le Coarer E. "Design of a new compact Static Fourier Transform Spectrometer in integrated optics based on a leaky loop structure," Opt. Lett.
 34 184–186 (2009).
- 16. Pohl D., Escalé M. R., Madi M., Kaufmann F., Brotzer P., Sergeyev A., Guldimann B., Giaccari P., Alberti E., Meier
 U. and Grange R. "An integrated broadband spectrometer on thin-film lithium niobate," Nat. Photonics 14 24–29
 (2020)
- 17. Cheng Y., Sugioka K., Midorikawa K., Masuda M., Toyoda K., Kawachi M., Shihoyama K. "Control of the cross-sectional shape of a hollow microchannel embedded in photostructurable glass by use of a femtosecond laser," Opt. Lett. 28 55--57 (2003).
- Osellame R., Taccheo S., Marangoni M., Ramponi R., Laporta P., Polli D., De Silvestri S., Cerullo G. "Femtosecond writing of active optical waveguides with astigmatically shaped beams," J. Opt. Soc. Am. B 20 1559–1567 (2003).
- 19. Welch P. "The use of fast Fourier transform for the estimation of power spectra: a method based on time averaging
 over short, modified periodograms," IEEE Transactions on audio electroacoustics 15 70–73 (1967).